Search Notes

	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/608,923	VARSHNEY ET AL.
	Examiner	Art Unit	
	Thai D. Hoang	2616	

SEARCHED

Class	Subclass	Date	Examiner
370	335	5/1/2007	TH
	342	5/1/2007	TH
455	42+	5/1/2007	TH
	102-104	5/1/2007	TH
	110-112	5/1/2007	TH
375	140-143	5/1/2007	TH
	146-147	5/1/2007	TH
	260-264	5/1/2007	TH
370	208-210	5/1/2007	TH

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST: TEXT SEARCH, SEE SEARCH HISTORY PRINTED OUT.	5/1/2007	TH
NPL: IEEE AND IETF	5/2/2007	TH

INTERFERENCE SEARCHED

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